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Isolated High Current Gate Driver

Product Preview

NCD57100, NCD57101, NCV57100, NCV57101

NCx5710y is a high-current single channel IGBT / SiC / MOSFET driver with internal galvanic isolation, designed for high system efficiency and reliability in high power applications. Its features include complementary inputs, open drain FAULT and READY outputs, active MILLER CLAMP, accurate UVLOs, DESAT protection and DESAT diagnostic function, soft turn-off at DESAT, Disable output function and separate high and low (OUTH and OUTL) driver outputs (NCx57100) for system design convenience. NCx5710y accommodates both 5 V and 3.3 V signals on the input side and wide bias voltage range on the driver side including negative voltage capability. NCx5710y provides > 5 kVrms (UL1577 rating) galvanic isolation and > 1424 $\rm V_{PK}$ (working voltage) capabilities. NCx5710y is available in the wide-body SOIC-16 package with guaranteed 8 mm creepage distance between input and output to fulfill reinforced safety insulation requirements.

Features

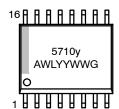
- High Current Peak Output (±7 A)
- Low Output Impedance for Enhanced Power Switch Driving
- Short Propagation Delays with Accurate Matching
- Active Miller Clamp to Prevent Spurious Gate Turn-on
- DESAT Protection with Programmable Delay
- DESAT Diagnostic Function (DSCHK)
- Output Disable Function
- Negative Voltage (Down to -8 V) Capability for DESAT
- Soft Turn Off During Power Switch Short Circuit
- Gate Clamping During Short Circuit
- Tight UVLO Thresholds for Bias Flexibility
- Wide Bias Voltage Range including Negative VEE2
- 3.3 V to 5 V Input Supply Voltage
- Designed for AEC–Q100 Certification
- 5000 V Galvanic Isolation (to meet UL1577 Requirements)
- 1424 V_{PK} / 1000 V_{RMS} Working Voltage (per VDE0884–11 Requirements)
- High Transient Immunity
- High Electromagnetic Immunity
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

Typical Applications

- Automotive Applications
- Solar Inverters
- Motor Control
- Welding



MARKING DIAGRAM



5710y = Specific Device Code

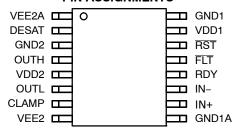
(y = 0 or 1)

A = Assembly Location

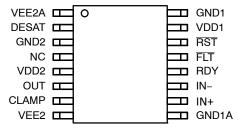
WL = Wafer Lot YY = Year WW = Work Week

G = Pb-Free Package

PIN ASSIGNMENTS



NCx57100 (x = D or V)



NCx57101 (x = D or V)

ORDERING INFORMATION

See detailed ordering and shipping information on page 10 $\,$ of this data sheet.

This document contains information on a product under development. **onsemi** reserves the right to change or discontinue this product without notice.

- Industrial Power Supplies
- Uninterruptible Power Supplies (UPS)

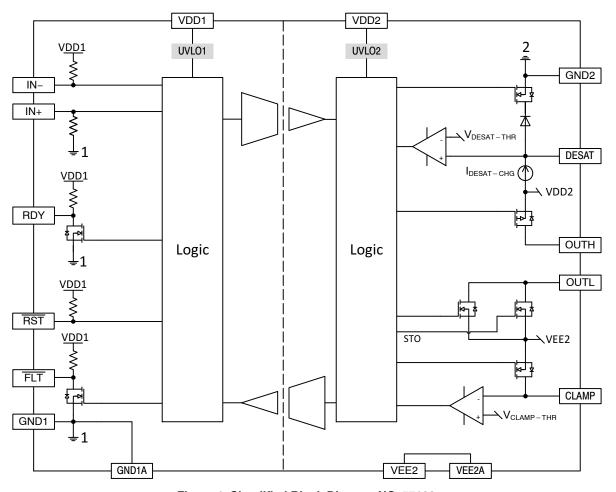


Figure 1. Simplified Block Diagram NCx57100

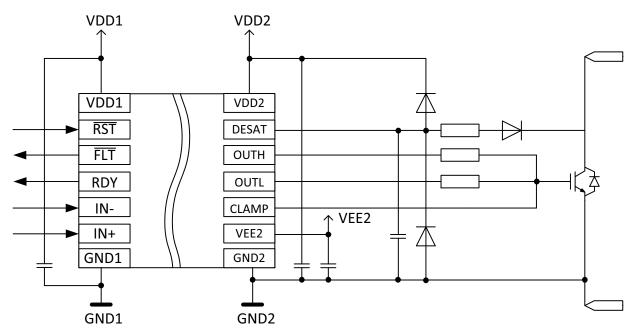


Figure 2. Simplified Application Schematics NCx57100

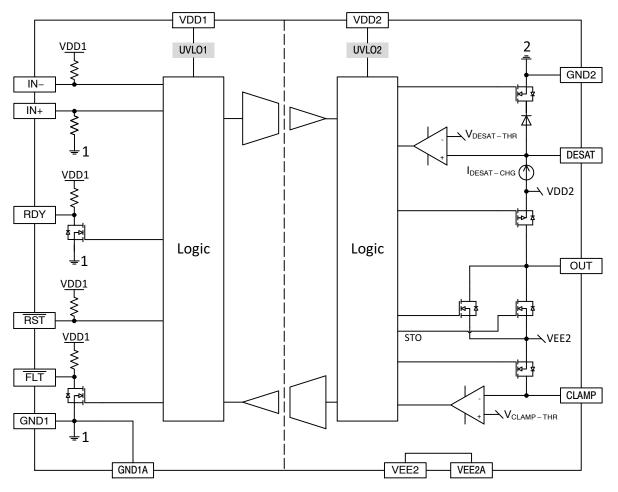


Figure 3. Simplified Block Diagram NCx57101

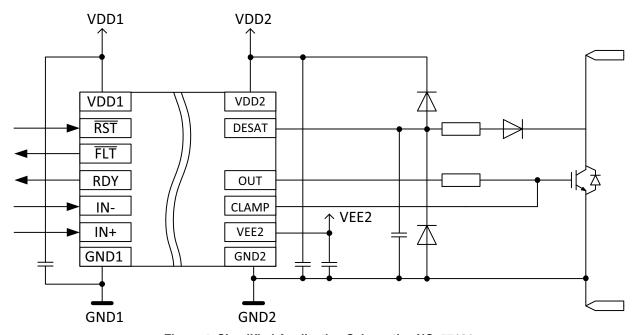


Figure 4. Simplified Application Schematics NCx57101

PIN DESCRIPTION

Vee2	Pin Name	No.	I/O	Description
DESAT 2 I/O			Power	to GND2 and should be placed close to the pins for best results. Connect it to GND2 for unipolar supply application. VEE2 and VEE2A pins are internally connected together, for better package
constant current source pcsar_c-ptc charging an external capacitor connected to this pin allows a programmable blanking delay every ON cycle before DESAT fault is processed, thus preventing false triggering. When the DESAT voltage goes up and reaches VpcsAT_hip. the output is deviced please refer to Figure 7 on page 13. A 5 μs mute time applies to IN+ and IN- once DESAT occurs. GND2 3 Power Output side gate drive reference connecting to IGBT emitter or FET source. OUTH (NCx57101) N/C DIVEN (NCX57101) VDD2 5 Power Output side positive power supply. The operating range for this pin is from UVLO2 to its maximum allowed value. A good quality bypassing capacitor is required from this pin to GND2 and should be placed close to the pins for best results. OUTL (NCx57100) OUTL (NCx57100) OUT (NCx57100) OUT (NCx57100) Fiver low output that provides the appropriate drive voltage and sink current to the power switch gate. Driver low output that provides the appropriate drive voltage and sink current to the power switch gate. Driver low output that provides the appropriate drive voltage and sink current to the power switch gate. OUT (NCx57101) CLAMP 7 I/O Provides clamping for the power switch gate during the off period to prove the power switch gate. GND1A 9 Power Input side ground reference. GND1 and GND1A pins are internally connected together, for better and the provention of the fire through a plant pin falls below (Pcg + VCLAMP-THR. It is to be tited directly to power switch gate with minimum trace length for best results. IN- 10 II Non inverted gate driver input. It is infernally clamped to V _{DD1} and has a pull-up resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN- before OUTx respond. Power good indication output, active high when V _{DD1} and N _{DD2} are both good. There is an internal So kΩ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OP" ed together. OUTx	V _{EE2}	8		connection is recommended. Thermal cooling polygons should be applied to these pins for better
GND2 3 Power Output side gate drive reference connecting to IGBT emitter or FET source.	DESAT	2	I/O	constant current source I _{DESAT-CHG} charging an external capacitor connected to this pin allows a programmable blanking delay every ON cycle before DESAT fault is processed, thus preventing false triggering. When the DESAT voltage goes up and reaches V _{DESAT-THB} , the output is driven low. Further, the /FLT output is activated, please refer to Figure 7 on page 13.
OUTH (NCx57100) A				
Not Connected Not Connected	GND2	3		· · · · · · · · · · · · · · · · · · ·
No.		4	0	
allowed value. A good quality bypassing capacitor is required from this pin to GND2 and should be placed close to the pins for best results. OUT (NCx57101) OUT (NCx57101) OUT (NCx57101) CLAMP 7 I/O Provides clamping for the power switch gate during the off period to protect it from parasitic turnon. Its internal NFET is turned on when the voltage of this pin falls below V _{EE2} + V _{CLAMP-THR} . It is to be tied directly to power switch gate with minimum trace length for best results. GND1A 9 Power Input side ground reference, GND1 and GND1A pins are internally connected together, for better package cooling of the driver, reduction of interference and negative effects of the floating pins, an external connection is recommended. Thermal cooling polygons should be applied to these pins for 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN+ before OUTx respond. IN- 11 Inverted gate driver input. It is internally clamped to V _{DD1} and has a pull-up resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN+ before OUTx respond. RDY 12 O Power good indication output, active high when V _{DD1} and has a pull-up resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN- before OUTx respond. RDY 12 O Power good indication output, active high when V _{DD1} and bas a pull-up resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN- before OUTx respond. FLT 13 O Fault output (active low) that allows communication to the main controller that the driver has encountered a desaturation condition and has deactivated the output. There is an internal 50 kΩ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. IN 14 I RESET				Not Connected
QUT (NCx57101) Qate. Driver low output that provides the appropriate drive voltage and sink current to the power switch gate. Driver low output that provides the appropriate drive voltage and sink current to the power switch gate. Driver low output that provides the appropriate drive voltage and sink current to the power switch gate. Provides clamping for the power switch gate during the off period to protect it from parasitic turnon. Its internal NFET is turned on when the voltage of this pin falls below V _{EE2} + V _{CLAMP} -THR. It is to be tied directly to power switch gate with minimum trace length for best results.	V_{DD2}	5	Power	allowed value. A good quality bypassing capacitor is required from this pin to GND2 and should be
CLAMP 7		6	0	
On. Its internal NFET is turned on when the voltage of this pin falls below V _{EE2} + V _{CLAMP-THR} . It is to be tied directly to power switch gate with minimum trace length for best results. GND1				, , , , , , , , , , , , , , , , , , , ,
Package cooling of the driver, reduction of interference and negative effects of the floating pins, an external connection is recommended. Thermal cooling polygons should be applied to these pins for better cooling of the case. IN+ 10 I Non inverted gate driver input. It is internally clamped to V _{DD1} and has a pull-down resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN+ before OUTx respond. IN- II I Inverted gate driver input. It is internally clamped to V _{DD1} and has a pull-up resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN- before OUTx respond. RDY I2 O Power good indication output, active high when V _{DD1} and V _{DD2} are both good. There is an internal 50 kΩ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. OUTx remain low when RDY is low. Short time delays may apply. See Figure 6 on page 12 for details. Fault output (active low) that allows communication to the main controller that the driver has encountered a desaturation condition and has deactivated the output. There is an internal 50 kΩ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. I I RESET: Reset input with an internal 50 kΩ pull-up resistor, active low to reset fault latch. 2) DISABLE: Active low to disable output function 3) DSCHK: Activation of DESAT comparator check function. The DSCHK is activated after input of 15 pulses with 200 ns Low pulse width and 10 μs High pulse width (see Page 23)	CLAMP	7	I/O	on. Its internal NFET is turned on when the voltage of this pin falls below $V_{EE2} + V_{CLAMP-THR}$. It is
IN+ 10 Inverted gate driver input. It is internally clamped to V _{DD1} and has a pull-down resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse—width is required at IN+ before OUTx respond. IN- I	GND1A	9	Power	package cooling of the driver, reduction of interference and negative effects of the floating pins, an
SO kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN+ before OUTx respond. Inverted gate driver input. It is internally clamped to V _{DD1} and has a pull-up resistor of 50 kΩ to ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse-width is required at IN- before OUTx respond. RDY 12 O Power good indication output, active high when V _{DD1} and V _{DD2} are both good. There is an internal 50 kΩ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. OUTx remain low when RDY is low. Short time delays may apply. See Figure 6 on page 12 for details. FLT 13 O Fault output (active low) that allows communication to the main controller that the driver has encountered a desaturation condition and has deactivated the output. There is an internal 50 kΩ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. RST 14 I RESET: Reset input with an internal 50 kΩ pull-up resistor, active low to reset fault latch. 2) DISABLE: Active low to disable output function 3) DSCHK: Activation of DESAT comparator check function. The DSCHK is activated after input of 15 pulses with 200 ns Low pulse width and 10 μs High pulse width (see Page 23)		16		better cooling of the case.
ensure that output is low in the absence of an input signal. A minimum positive or negative going pulse—width is required at IN—before OUTx respond. RDY 12 O Power good indication output, active high when V _{DD1} and V _{DD2} are both good. There is an internal 50 kΩ pull—up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. OUTx remain low when RDY is low. Short time delays may apply. See Figure 6 on page 12 for details. /FLT 13 O Fault output (active low) that allows communication to the main controller that the driver has encountered a desaturation condition and has deactivated the output. There is an internal 50 kΩ pull—up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. /RST 14 I 1) RESET: Reset input with an internal 50 kΩ pull—up resistor, active low to reset fault latch. 2) DISABLE: Active low to disable output function 3) DSCHK: Activation of DESAT comparator check function. The DSCHK is activated after input of 15 pulses with 200 ns Low pulse width and 10 μs High pulse width (see Page 23)	IN+	10	_	50 k Ω to ensure that output is low in the absence of an input signal. A minimum positive or nega-
50 kΩ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. OUTx remain low when RDY is low. Short time delays may apply. See Figure 6 on page 12 for details. FLT	IN-	11	I	ensure that output is low in the absence of an input signal. A minimum positive or negative going
encountered a desaturation condition and has deactivated the output. There is an internal 50 kΩ pull–up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. 1 I RESET: Reset input with an internal 50 kΩ pull–up resistor, active low to reset fault latch. 2 DISABLE: Active low to disable output function 3 DSCHK: Activation of DESAT comparator check function. The DSCHK is activated after input of 15 pulses with 200 ns Low pulse width and 10 μs High pulse width (see Page 23)	RDY	12	0	$50~k\Omega$ pull-up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed together. OUTx remain low when RDY is low. Short time delays may apply. See Figure 6 on page 12 for
2) DISABLE: Active low to disable output function 3) DSCHK: Activation of DESAT comparator check function. The DSCHK is activated after input of 15 pulses with 200 ns Low pulse width and 10 µs High pulse width (see Page 23)	/FLT	13	0	encountered a desaturation condition and has deactivated the output. There is an internal 50 k Ω pull–up resistor connected to this pin. Multiple of them from different drivers can be "OR"ed
V _{DD1} 15 Power Input side power supply (3.3 V to 5 V).	/RST	14	I	2) DISABLE: Active low to disable output function 3) DSCHK: Activation of DESAT comparator check function. The DSCHK is activated after input of
	V _{DD1}	15	Power	Input side power supply (3.3 V to 5 V).

SAFETY AND INSULATION RATINGS

Symbol	Parameter	Value	Unit	
		150 V _{RMS}	I – IV	
	Table 1 Rated Mains Voltage	300 V _{RMS}	I – IV	
	<	450 V _{RMS}	I – IV	
	<	600 V _{RMS}	I – IV	
	<	1000 V _{RMS}	I – III	
CTI	Comparative Tracking Index (DIN IEC 112/VDE 0303 Part 1)		600	
	Climatic Classification		40/125/21	
	Polution Degree (DIN VDE 0110/1.89)	2		
V_{PR}	Input–to–Output Test Voltage, Method B, V_{IORM} x 1.875 = V_{PR} , 100% Production tm = 1 s, Partial Discharge < 5 pC	2670	V_{pk}	
V_{IORM}	Maximum Repetitive Peak Voltage	1424	V_{pk}	
V_{IOWM}	Maximum Working Voltage		1000	V_{RMS}
V _{IOTM}	Highest Allowable Over Voltage		8490	V_{pk}
E _{CR}	External Creepage		8.0	mm
E _{CL}	External Clearance	8.0	mm	
DTI	Insulation Thickness	17.3	um	
T _{Case}	Safety Limit Values – Maximum Values in Failure; Case Temperature	150	°C	
P _{S,INPUT}	Safety Limit Values – Maximum Values in Failure; Input Power	36	mW	
P _{S,OUTPUT}	Safety Limit Values – Maximum Values in Failure; Output Power	1364	mW	
R _{IO}	Insulation Resistance at TS, V _{IO} = 500 V	10 ⁹	Ω	

ABSOLUTE MAXIMUM RATINGS (Over operating free-air temperature range unless otherwise noted) (Note 1)

Symbol	Parameter	Minimum	Maximum	Unit
V _{DD1} -GND1	Supply voltage, input side	-0.3	6	V
V _{DD2} -GND2	Positive Power Supply, output side	-0.3	36	V
V _{EE2} -GND2	Negative Power Supply, output side	-18	0.3	V
V _{DD2} -V _{EE2} (V _{MAX2})	Differential Power Supply, output side	-0.3	36	V
V _{OUTH}	Positive gate-driver output voltage	V _{EE2} - 0.3	V _{DD2} + 0.3	V
V _{OUTL}	Negative gate-driver output voltage	V _{EE2} - 0.3	V _{DD2} + 0.3	V
I _{PK-SRC}	Gate-driver output sourcing current (maximum pulse width = 10 μ s, maximum duty cycle = 0.2%, V_{DD2} = +15 V, V_{EE2} = -8 V)	-	7.8	Α
I _{PK-SNK}	Gate-driver output sinking current (maximum pulse width = 10 μ s, maximum duty cycle = 0.2%, V_{DD2} = +15 V, V_{EE2} = -8 V)		7.1	Α
I _{PK-CLAMP}	$I_{PK-CLAMP}$ Clamp sinking current (maximum pulse width = 10 μs, maximum duty cycle = 0.2%, V_{CLAMP} = 2.5 V)		2.5	Α
t _{CLP}	Maximum Short Circuit Clamping Time (I _{OUTH_CLAMP} = 500 mA)	_	10	μs
V _{LIM} -GND1	Voltage at IN+, IN-, /RST, /FLT, RDY	-0.3	V _{DD1} + 0.3	V
I _{LIM} -GND1	Output current of /FLT, RDY	-	10	mA
V _{DESAT} -GND2	Desat Voltage (Note 2)	-9	V _{DD2} + 0.3	V
V _{CLAMP} -V _{EE2}	Clamp Voltage	V _{EE2} - 0.3	V _{DD2} + 0.3	V
P _D	Power Dissipation (Note 3)	-	1400	mW
T _{J(max)}	Maximum Junction Temperature	-40	150	°C
T _{STG}	Storage Temperature Range	-65	150	°C
ESD _{HBM}	ESD Capability, Human Body Model (Note 4)	-	±2	kV
ESD _{CDM}	ESD Capability, Charged Device Model (Note 4)		±1.5	kV
MSL	Moisture Sensitivity Level	-	1	-
T _{SLD}	Lead Temperature Soldering Reflow, Pb-Free Versions (Note 5)	-	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Refer to ELECTRICAL CHĂRACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.
- The minimum value is verified by characterization with a single pulse of 1.5 mA for 300 µs.
- 3. The value is estimated for ambient temperature 25°C and junction temperature 150°C, 650 mm², 1 oz copper, 2 surface layers and 2 internal power plane layers. Power dissipation is affected by the PCB design and ambient temperature.

 4. This device series incorporates ESD protection and is tested by the following methods:
- - ESD Human Body Model tested per AEC-Q100-002 (EIA/JESD22-A114)
 - ESD Charged Device Model tested per AEC-Q100-011 (EIA/JESD22-C101)
 - Latchup Current Maximum Rating: ≤100 mA per JEDEC standard: JESD78, 25°C
- 5. For information, please refer to our Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Conditions	Value	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Air	100 mm ² , 2 oz Copper, 1 Surface Layer	95	°C/W
		100 mm ² , 2 oz Copper, 2 Surface Layers and 2 Internal Power Plane Layers	71	

RECOMMENDED OPERATING RANGES (Note 6)

Symbol	Parameter	Min	Max	Unit
V _{DD1} -GND1	Supply voltage, input side	UVLO1	5.5	V
V _{DD2} -GND2	Positive Power Supply, output side	UVLO2	32	V
V _{EE2} -GND2	Negative Power Supply, output side	-16	0	V
V _{DD2} -V _{EE2} (V _{MAX2})	Differential Power Supply, output side	0	32	V
V _{IL}	Low level input voltage at IN+, IN-, /RST	0	0.3 X V _{DD1}	V
V _{IH}	High level input voltage at IN+, IN-, /RST	0.7 X V _{DD1}	V_{DD1}	V
dV _{ISO} /dt	Common Mode Transient Immunity (Note 10)	150	-	kV/μs
T _A	Ambient Temperature	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

6. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

ISOLATION CHARACTERISTICS

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{ISO} , input-output	Input-Output Isolation Voltage	T_A = 25°C, Relative Humidity < 50%, t = 1.0 minute, I_{I-O} <30 $\mu A,$ 50 Hz (Note 7, 8, 9)	5000	ı	ı	V _{RMS}
R _{ISO}	Isolation Resistance	V _{I-O} = 500 V (Note 7)	-	10 ¹¹	-	Ohm

- 7. Device is considered a two-terminal device: pins 1 to 8 are shorted together and pins 9 to 16 are shorted together.
- 8. 5,000 V_{RMS} for 1-minute duration is equivalent to 6,000 V_{RMS} for 1-second duration.

ELECTRICAL CHARACTERISTICS ($V_{DD1} = 5 \text{ V}$, $V_{DD2} = 15 \text{ V}$, $V_{EE2} = -8 \text{ V}$. For typical values $T_A = 25^{\circ}\text{C}$, for min/max values, T_A is the operating ambient temperature range that applies, unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OLTAGE SUPPLY		•	•	•		•
V _{UVLO1-OUT-ON}	UVLO1 Output Enabled		-	-	3.05	V
V _{UVLO1-OUT-OFF}	UVLO1 Output Disabled		2.4	-	_	V
V _{UVLO1-HYST}	UVLO1 Hysteresis		0.1	0.125	-	٧
V _{UVLO2-OUT-ON}	UVLO2 Output Enabled		12.7	13	13.3	V
V _{UVLO2-OUT-OFF}	UVLO2 Output Disabled		11.7	12	12.3	V
V _{UVLO2-HYST}	UVLO2 Hysteresis		0.8	1		٧
I _{DD1-0}	Input Supply Quiescent Current Output Low	IN+ = Low, IN- = Low RDY = High, /FLT = High	-	1	2	mA
I _{DD1-100}	Input Supply Quiescent Current Output High	IN+ = High, IN- = Low RDY = High, /FLT = High	-	6	7.5	mA
I _{DD2-0}	Output Positive Supply Quiescent Current, Output Low	IN+ = Low, IN- = Low RDY = High, /FLT = High, no load	-	3.3	4	mA
I _{DD2-100}	Output Positive Supply Quiescent Current, Output High	IN+ = High, IN- = Low RDY = High, /FLT = High, no load	-	3.6	4	mA
I _{EE2-0}	Output Negative Supply Quiescent Current, Output Low	IN+ = Low, IN- = High, no load	-	0.2	2	mA
I _{EE2-100}	Output Negative Supply Quiescent Current, Output High	IN+ = High, IN- = Low, no load	-	0.2	2	mA
OGIC INPUT AND	OUTPUT	•		•		-
V _{IL}	IN+, IN−, /RST Low Input Voltage		-	_	0.3 x V _{DD1}	٧

The input-output isolation voltage is a dielectric voltage rating per UL1577. It should not be regarded as an input-output continuous voltage
rating. For the continuous working voltage rating, refer to equipment-level safety specification or DIN VDE V 0884-11 Safety and Insulation
Ratings Table.

ELECTRICAL CHARACTERISTICS ($V_{DD1} = 5 \text{ V}$, $V_{DD2} = 15 \text{ V}$, $V_{EE2} = -8 \text{ V}$. For typical values $T_A = 25^{\circ}\text{C}$, for min/max values, T_A is the operating ambient temperature range that applies, unless otherwise noted) (continued)

Symbol	Parameter Test Condition		Min	Тур	Max	Unit
OGIC INPUT AND	ООПТРИТ		-	-	-	
V _{IH}	IN+, IN-, /RST High Input Voltage		0.7 x V _{DD1}	-	-	V
V _{IN-HYST}	Input Hysteresis Voltage		-	0.15 x V _{DD1}	-	V
I _{IN-L} , I _{RST-L}	IN-, /RST Input Current (50 kΩ pull-up resistor)	V _{IN-} , V _{RST} = 0 V	-	-100	-	μΑ
I _{IN+H}	IN+ Input Current (50 kΩ pull-down resistor)	V _{IN+} = 5 V	-	100	-	μΑ
I _{RDY-L} , I _{FLT-L}	RDY, /FLT Pull-up Current (50 kΩ pull-up resistor)	V _{RDY} , V _{FLT} = Low	-	100	-	μΑ
V _{RDY-L} , V _{FLT-L}	RDY, /FLT Low Level Output Voltage	I _{RDY} , I _{FLT} = 5 mA	-	-	0.3	٧
t _{MIN1}	Input Pulse Width of IN+, IN-, /RST for No Response at Output		-	_	10	ns
t _{MIN2}	Input Pulse Width of IN+, IN-, /RST for Guaranteed Response at Output		40	_	-	ns
t _{RST-MIN}	Pulse Width of /RST for Resetting /FLT		800	-	1	ns
RIVER OUTPUT						
V _{OUTL1}	Output Low State	I _{SINK} = 200 mA	-	0.1	0.2	V
V _{OUTL3}	(V _{OUTL} – V _{EE2})	I _{SINK} = 1.0 A, T _A = 25°C	-	0.7	0.8	1
V _{OUTL4}	7	$I_{SINK} = 1.0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	-	-	1	1
V _{OUTH1}	Output High State	I _{SRC} = 200 mA	-	0.3	0.5	V
V _{OUTH3}	(V _{DD2} – V _{OUTH})	I _{SRC} = 1.0 A, T _A = 25°C	_	0.9	1	1
V _{OUTH4}	7	$I_{SRC} = 1.0 \text{ A}, T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$	-	-	1.5	1
I _{PK-SNK1}	Peak Driver Current, Sink (Note 10)		-	7.1	-	Α
I _{PK-SRC1}	Peak Driver Current, Source (Note 10)		-	7.8	-	Α
I _{PK-SNK-STO}	Soft Turn Off Sinking Current (Note 10)	$V_{EE2} = -8 \text{ V}, T_A = 25^{\circ}\text{C},$ $C_G = 100 \text{ nF}, R_G = 0 \Omega$	-	200	-	mA
IILLER CLAMP			-			-
V _{CLAMP}	Clamp Voltage	I _{CLAMP} = 2.5 A, T _A = 25°C	-	1.7	1.9	V
	(VCLAMP - VEE2)	I_{CLAMP} = 2.5 A, T_A = -40°C to 125°C	-	-	2.7	1
V _{CLAMP} -THR	Clamp Activation Threshold (V _{CLAMP} – V _{EE2})		1.5	2	2.5	V
OWER SWITCH S	SHORT CIRCUIT CLAMPING					
V _{CLAMP-OUT}	Clamping Voltage, Sourcing (NCx57100: V _{OUTH} -V _{DD2} , NCx57101: V _{OUT} -V _{DD2})	I _{CLAMP-OUT} = 500 mA (pulse test, t _{CLPmax} = 10 μs)	_	0.9	1.1	V
ESAT PROTECTI	ON					
V _{DESAT-THR}	DESAT Threshold Voltage		8.5	9	9.5	٧
V _{DESAT-NEG}	DESAT Negative Voltage	I _{DESAT} = 1.5 mA	-8	-	-	٧
I _{DESAT-CHG}	Blanking Charge Current	V _{DESAT} = 7 V	0.4	0.5	0.6	mA
I _{DESAT-DIS}	Blanking Discharge Current		-	50	-	mA
ESAT CHECK FU	NCTIONS (DSCHK)		•	•		-
t _{RST-ACT1}	Negative Input Pulse Width to (see Figure 9) activate DSCHK function			200	-	ns

ELECTRICAL CHARACTERISTICS ($V_{DD1} = 5 \text{ V}$, $V_{DD2} = 15 \text{ V}$, $V_{EE2} = -8 \text{ V}$. For typical values $T_A = 25^{\circ}\text{C}$, for min/max values, T_A is the operating ambient temperature range that applies, unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
t _{RST-ACT}	Input Pulse Width to activate DSCHK function	15 LOW pulses t _{RST-ACT} on /RST pin (see Figure 9)	8	_	10	μs
ABLE OUTPUT	•					
t _{RST-DIS}	Output disable function propagation delay (Note 10)	V _{IL} pulse width higher than t _{MIN2} on /RST pin to 90% of OUTx to disable output	-	-	90	ns
NAMIC CHARA	CTERISTICS					
t _{PD-ON}	IN+, IN- to Output High Propagation Delay	C _{LOAD} = 10 nF V _{IH} to 10% of pulse width higher than t _{MIN2} . OUTx and CLAMP pins are connected together	50	70	90	ns
t _{PD-OFF}	IN+, IN- to Output Low Propagation Delay	C _{LOAD} = 10 nF V _{IL} to 90% of pulse width higher than t _{MIN2} . OUTx and CLAMP pins are connected together	50	70	90	ns
t _{DISTORT}	Propagation Delay Distortion (= t _{PD-ON} - t _{PD-OFF})	$T_A = 25$ °C, pulse width higher than t_{MIN2}	-15	0	15	ns
		$T_A = -40$ °C to 125°C, pulse width higher than t_{MIN2}	-25	-	25	
t _{DISTORT_TOT}	Prop Delay Distortion between Parts	PW > 150 ns	-30	0	30	ns
t _{RISE}	Rise Time (see Fig. 5) (Note 10)	C _{LOAD} = 1 nF, 10% to 90% of Output Change	-	15	-	ns
t _{FALL}	Fall Time (see Fig. 5) (Note 10)	C _{LOAD} = 1 nF, 90% to 10% of Output Change	-	15	-	ns
t _{LEB}	DESAT Leading Edge Blanking Time (see Fig. 7)		-	400	-	ns
t _{FILTER}	DESAT Threshold Filtering Time (see Fig. 7)		-	360	-	ns
t _{FLT}	Delay after t _{FILTER} to /FLT		_	450	_	ns
t _{MUTE}	DESAT Mute time after t _{FILTER}		_	5	-	μs
t _{RST}	/RST Rise to /FLT Rise Delay		_	23	100	ns
t _{UV1F}	UVLO1 Filter time (see Fig. 6) (Note 10)		-	1	-	μs
t _{UV1R}	V _{UVLO1 OUT ON} to RDY High Delay (see Fig. 6) (Note 10)		-	250	-	ns
t _{RDY1F}	UVLO1 to RDY Low Delay (see Fig. 6) (Note 10)		-	10	-	ns
t _{RDY10}	RDY High to Output High Delay		-	55	-	ns
t _{RDY20}	(see Fig. 6)					
t _{UV2R}	UVLO2 Filter time (see Fig. 6)		-	2.5	-	μs
t _{UV2F}	7					
t _{RDY2F}	V _{UVLO2_OUT_OFF} to RDY Low Delay (see Fig. 6)		-	5	-	μs
t _{RDY2R}	V _{UVLO2 OUT ON} to RDY High Delay (see Fig. 6) (Note 10)		-	2.6	_	μs

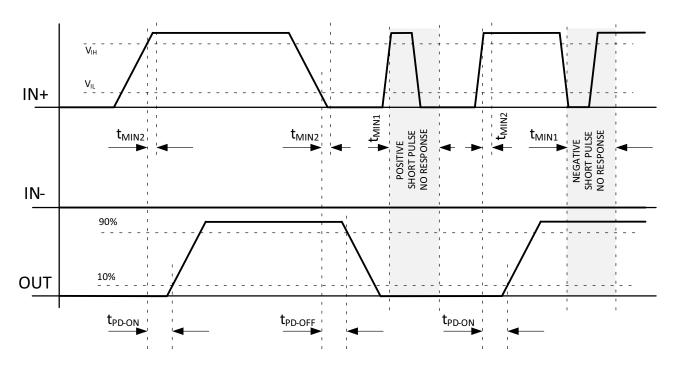
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

10. Values based on design and/or characterization.

ORDERING INFORMATION

Device	Qualification	Package Type	Shipping [†]
NCD57100DWR2G	NCD – Industry NCV – Automotive	SOIC-16 Wide Body	1,000 / Tape & Reel
NCV57100DWR2G	NGV - Automotive	(Pb-Free)	
NCD57101DWR2G			
NCV57101DWR2G			

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



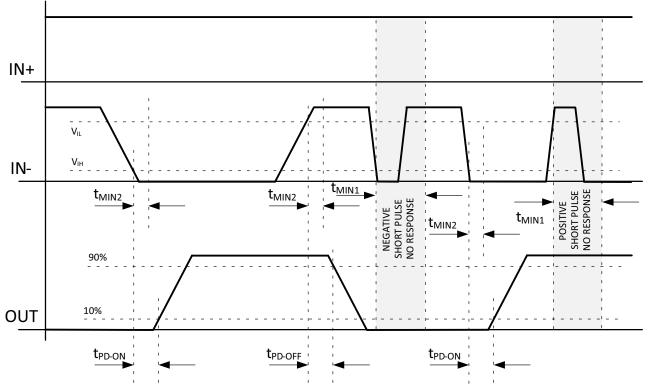


Figure 5. Propagation Delay, Rise and Fall Time

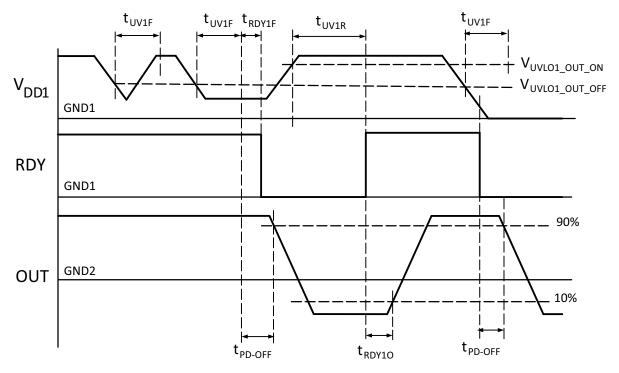


Figure 6a. UVLO1 Waveform

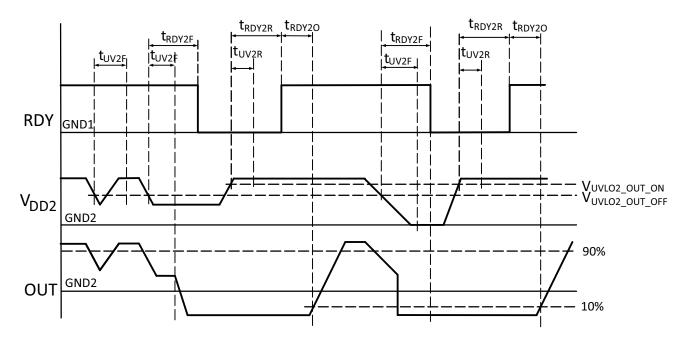


Figure 6b. UVLO2 Waveform

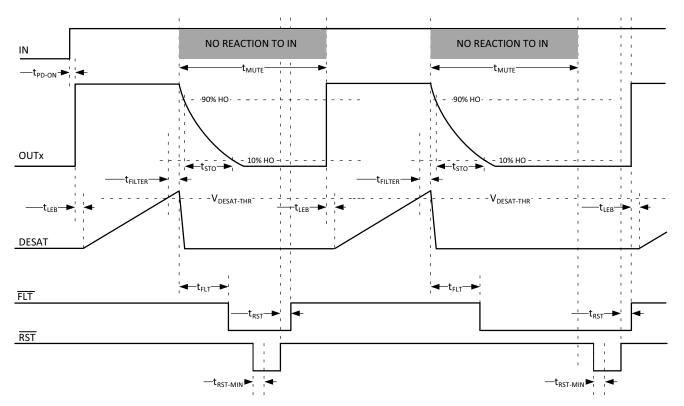


Figure 7. DESAT Response Waveform

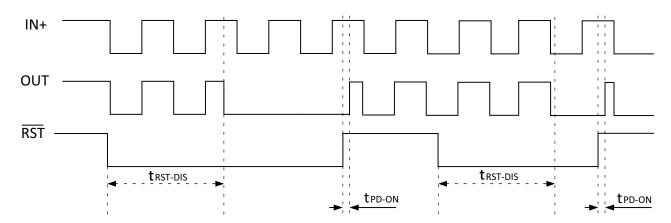


Figure 8. DISABLE

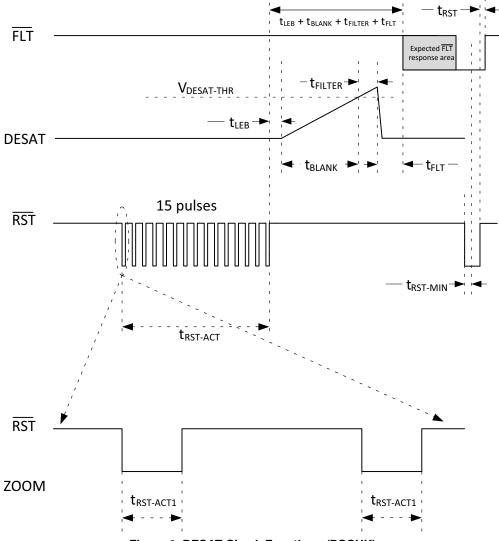


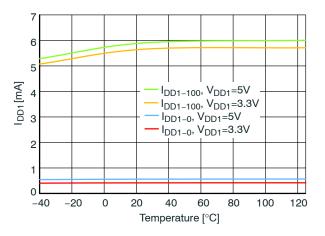
Figure 9. DESAT Check Functions (DSCHK)

TRUTH TABLE

IN	UVLO1	UVLO2	DESAT*	OUT	/RST	RDY	/FLT	Notes
L	Inactive	Inactive	L	L	Х	7	7	Initial condition after power up V_{DD1} and V_{DD2}
7	Inactive	Inactive	L	7	Х	Н	Н	Initial condition – IN First Rising edge
Н	Inactive	Inactive	L	Н	Х	Н	Н	Normal Operation – Output High
L	Inactive	Inactive	L	L	Х	Н	Н	Normal Operation – Output Low
Х	Active	Inactive	Х	L	Х	L	L	UVLO1 Activated – RDY Low (t _{RDY1F}), /FLT Low, Output Low
Х	Inactive	Inactive	Х	Х	Х	Н	Н	UVLO1 Recovered - RDY High, /FLT High
Х	Inactive	Active	Х	L	Х	L	Н	UVLO2 Activated – RDY Low (t _{RDY2F}), Output Low
Х	Inactive	Inactive	Х	Х	Х	Н	Н	UVLO2 Recovered - RDY High, /FLT High
Н	Inactive	Inactive	H (>t _{FILTER})	L	Х	Н	L.	DESAT Activated – /FLT Low (t _{FLT}), Output Low
Х	Inactive	Inactive	L	Х	⅓ (>t _{RST})	Н	7	/FLT reset, DESAT conditions disappear, t _{RST} pulse applied
75	Inactive	Inactive	L	L	L (>t _{RST-DIS})	Н	Н	Output DISABLED
L	Inactive	Inactive	Х	L	15x t _{RST-ACT1}	Н	L	DESAT circuit check function activated

^{*} L = $V_{DESAT} < V_{DESAT-THR}$, H = $V_{DESAT} > V_{DESAT-THR}$

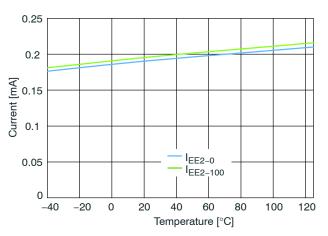
TYPICAL CHARACTERISTICS



3.2 3 Current [mA] I_{DD2-0} , V_{EE2} =-8VI_{DD2-100}, V_{EE2}=-8V 2.8 I_{DD2-0} , V_{EE2} =0V $I_{DD2-100}, V_{EE2}=0V$ 2.6 2.4 2.2 2 -20 0 40 80 100 120 -40 60 Temperature [°C]

Figure 10. V_{DD1} Supply Current

Figure 11. V_{DD2} Supply Current



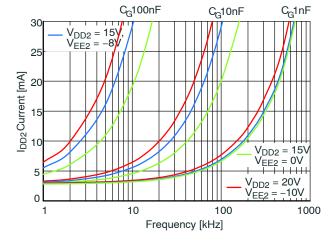
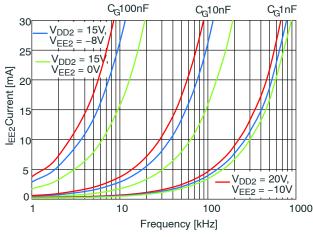


Figure 12. V_{EE2} Supply Current

Figure 13. V_{DD2} Supply Current vs. Frequency



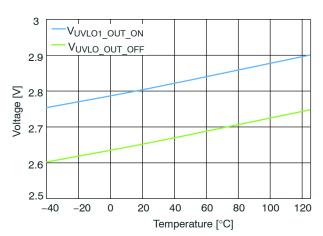


Figure 14. V_{EE2} Supply Current vs. Frequency

Figure 15. UVLO1 Threshold Voltage

TYPICAL CHARACTERISTICS

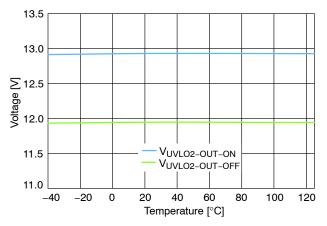


Figure 16. UVLO2 Threshold Voltage

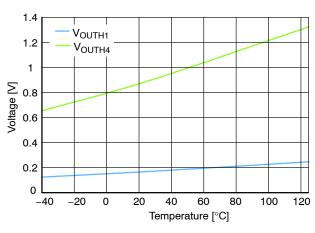


Figure 17. Output Voltage Drop, Sourcing

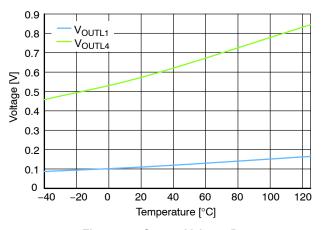


Figure 18. Output Voltage Drop, Sinking

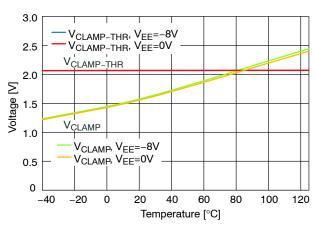


Figure 19. CLAMP Voltage Drop

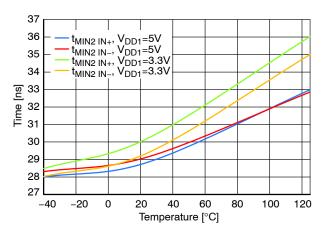


Figure 20. Minimum Pulse Width For Guaranteed Response

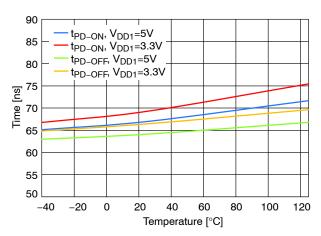
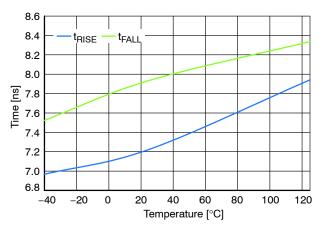


Figure 21. Propagation Delay

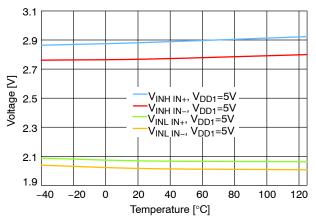
TYPICAL CHARACTERISTICS



4.0 $t_{STO}, V_{EE2} = -8\overset{'}{V} \\ t_{STO}, V_{EE2} = 0 \overset{'}{V}$ 3.0 Time [us] 2.0 1.0 0.0 20 40 60 80 100 120 -40 -20 Temperature [°C]

Figure 22. Rise and Fall Time

Figure 23. Soft Turn Off Time



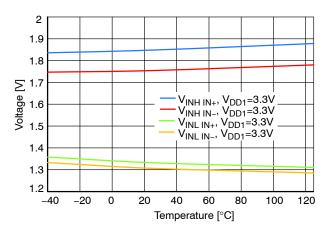
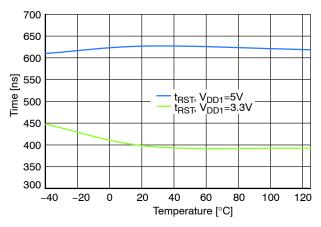


Figure 24. Input High Voltage Level, V_{DD1} = 5 V

Figure 25. Input High Voltage Level, $V_{DD1} = 3.3 \text{ V}$



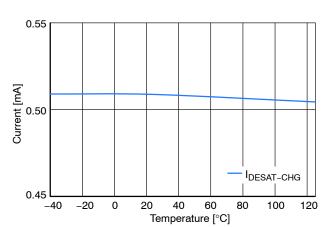
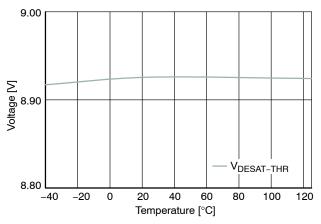


Figure 26. Minimum Fault Reset Time

Figure 27. Desat Charge Current

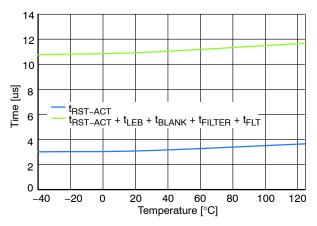
TYPICAL CHARACTERISTICS



60 | IDESAT-DIS, VEE2=-8V | IDESAT-DIS, VEE2=0V | IDESAT-DIS, VEE2

Figure 28. Desat Threshold Voltage

Figure 29. Desat Discharge Current



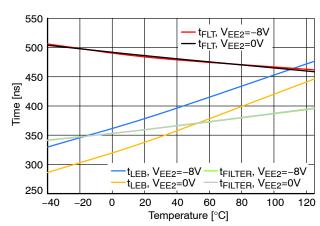
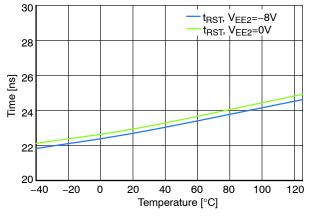


Figure 30. DESAT Check Activation (15 pulses 250 ns)

Figure 31. DESAT Time Parameters



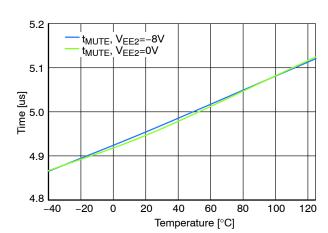
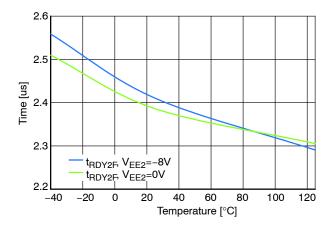


Figure 32. Reset to Fault Response Time

Figure 33. DESAT Mute Time

TYPICAL CHARACTERISTICS



46 $t_{RDY10}, V_{EE2}=-8V$ $t_{RDY10}, V_{EE2}=0V$ 44 42 Time [ns] 40 38 36 34 t_{RDY2O}, V_{EE2}=-8V 32 $t_{RDY2O},\,V_{EE2}\text{=}0V$ 30 60 80 100 -40 -20 20 40 120 Temperature [°C]

Figure 34. UVLO2 to RDY Delay

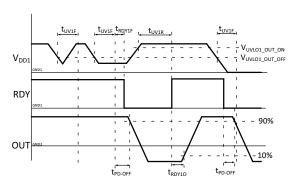
Figure 35. RDY to OUT Delay

FEATURE DESCRIPTIONS

Under Voltage Lockout (UVLO)

UVLO ensures correct switching of power switch connected to the driver output.

- \bullet The power switch is turned-off, if the supply V_{DD1} drops below $V_{UVLO1-OUT-OFF}$ and the RDY pin output goes to low.
- The driver output does not start to react to the input signal on V_{IN} until the V_{DD1} rises above the V_{UVLO1-OUT-ON} again. If the supply V_{DD1} increase over V_{UVLO1-OUT-ON}, the RDY pin output goes to be open-drain and outputs continue to switch power switch
- \bullet The power switch is turned–off, if the supply V_{DD2} drops below $V_{UVLO2-OUT-OFF}$ and the RDY pin output goes to low.
- The driver output does not start to react to the input signal on V_{IN} until the V_{DD2} rises above the V_{UVLO2-OUT-ON} again. If the supply V_{DD2} increases over V_{UVLO2-OUT-ON}, the RDY pin output goes to be open-drain and outputs continue to switch power switch
- VEE2 is not monitored.



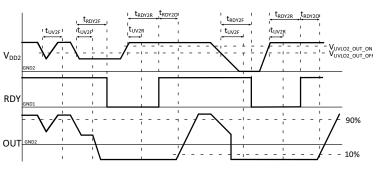


Figure 36. UVLO Diagram

Active Miller Clamp Protection (CLAMP)

NCx5710y supports both bipolar and unipolar power supply with active Miller clamp.

For operation with bipolar supplies, the power switch is turned off with a negative voltage through OUTL/OUT with respect to its emitter. This prevents the power switch from unintentionally turning on because of current induced from its collector to its gate due to Miller effect. In this condition it is not necessary to connect CLAMP output of the gate driver to the power switch gate, but connecting CLAMP output to the power switch gate is also not an issue. Typical values for bipolar operation are $V_{DD2} = 15 \text{ V}$ and $V_{EE2} = -8 \text{ V}$ with respect to GND₂.

For operation with unipolar supply, typically, $V_{DD2} = 15~V$ with respect to GND_2 , and $V_{EE2} = GND_2$. In this case, the power switch can turn on due to additional charge from power switch Miller capacitance caused by a high voltage slew rate transition on the power switch collector / Drain. To prevent power switch to turn on, the CLAMP pin is connected directly to power switch gate and Miller current is sunk through a low impedance CLAMP transistor. When the power switch is turned–off and the gate voltage transitions below $V_{CLAMP-THR}$, the CLAMP current output is activated.

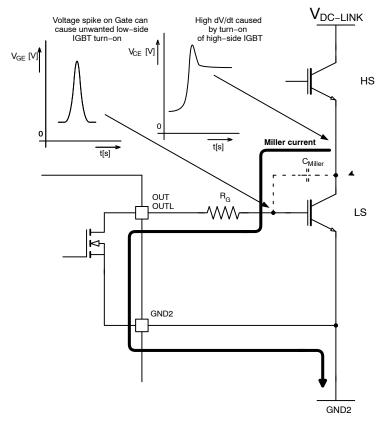


Figure 37. Current Path without Miler Clamp Protection

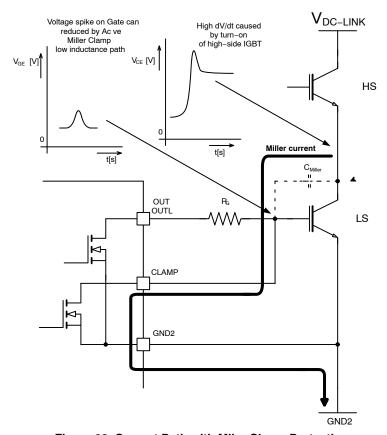


Figure 38. Current Path with Miler Clamp Protection

Non-inverting and Inverting Input Pin (IN+, IN-)

NCx5710y has two possible input modes to control power switch. Both inputs have defined minimum input pulse width to filter occasional glitches.

- Non-inverting input IN+ controls the driver output while inverting input IN- is set to LOW
- Inverting input IN- controls the driver output while non-inverting input IN+ is set to HIGH

Warning: When the application uses an independent or separate power supply for the control unit and the input side of the driver, all inputs should be protected by a serial resistor (In case of a power failure of the driver, the driver may be damaged due to overloading of the input protection circuits)

Desaturation Protection (DESAT)

Desaturation protection ensures the protection of power switch at short circuit. For example with IGBT power switch when the $V_{\text{CE-SAT}}$ voltage goes up and reaches the set limit, the output is driven low by Soft Turn Off and /FLT output is activated. Blanking time can be set by internal current source and an external capacitor. To avoid false DESAT triggering and minimize blanking time, fast switching diodes with low internal capacitance are recommended. All DESAT protective diodes internal capacitances build voltage divider with the blanking capacitor.

<u>Warning:</u> Both external protective diodes are recommended for the protection against voltage spikes caused by power switch transients passing through parasitic capacitances.

DESAT Circuit Parameters Specification

$$t_{BLANK} = C_{BLANK} \cdot \frac{V_{DESAT-THR}}{I_{DESAT-CHG}}$$

$$V_{DESAT-THR} > R_{S-DESAT} \cdot I_{DESAT-CHG} + V_{F HV diode} + V_{CESAT IGBT}$$

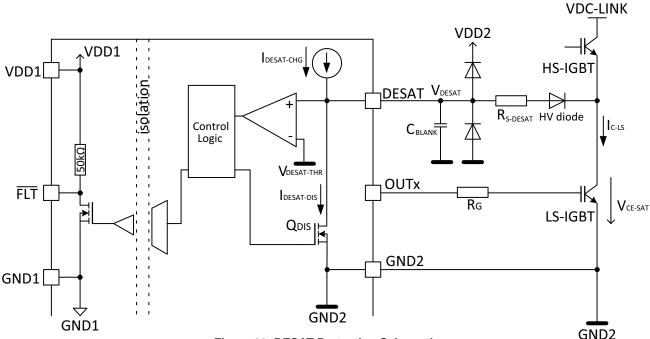


Figure 39. DESAT Protection Schematic

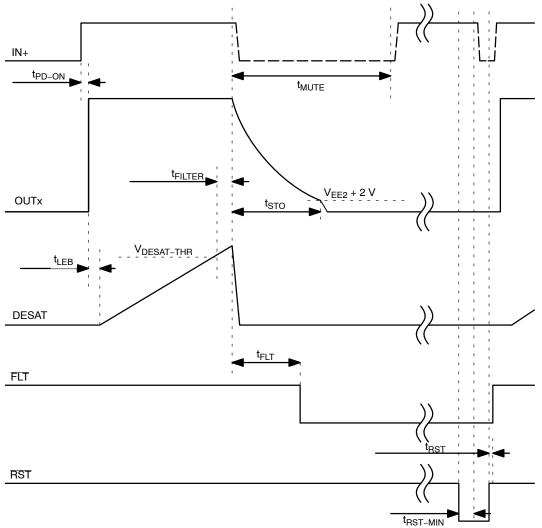


Figure 40. DESAT Switch Off Behavior

Fault Output Pin (FLT)

 \overline{FLT} open-drain output provides feedback to the controller about driver DESAT protection conditions. The open-drain \overline{FLT} outputs of multiple NCx5710y devices can be wired together forming a single, common fault bus for interfacing directly to the microcontroller. \overline{FLT} output has 50 k Ω internal pull-up resistor to VDD1.

Ready Output Pin (RDY)

RDY open-drain output provides feedback to the controller about driver UVLO protections conditions.

• If either side of device has insufficient supply (VDD1 or VDD2), the RDY pin output goes low; otherwise, RDY pin output is open drain.

The open-drain RDY outputs of multiple NCx5710y devices can be "OR"ed together.

Reset Input Pin (RST)

Reset input pin is **ACTIVE LOW** and has internal pull-up resistor to VDD1. In normal condition the \overline{RST} pin is connected to HIGH. To reset FAULT conditions or disable output pulses connect \overline{RST} pin to LOW. To invoke DESAT Check (DSCHK) function apply pulse sequence (see Figure 9).

In applications that do not allow to control the reset, \overline{RST} pin should be connected to IN+, the driver will be reset by each input pulse. In this case t_{MIN2} need to be longer than t_{RST} .

RESET Input has Three Functions:

- 1. Set back the \overline{FLT} output
- 2. It can be used as Disable/shutdown output (independent of the input logic)
- 3. It can be used to test DESAT circuit functionality
- ◆ To set back FLT output (if DESAT conditions are fulfilled and FLT output is activated), negative pulse of minimum length t_{RST} needs to be applied to RST pin. (see Figure 7.)

- To disable output, negative pulse of minimum length t_{RST-DIS} needs to be applied to RST pin. (see Figure 8.)
- To activate DESAT check function apply 15 negative pulses of t_{RST-ACT1} width and t_{RST-ACT} pulse Length (see Figure 9.)

Warning: When the application uses an independent or separate power supply for the control unit and the input side of the driver, all inputs should be protected by a serial resistor (in case of a power failure of the driver, the driver may be damaged due to overloading of the input protection circuits)

Power Supply (VDD1, VDD2, VEE2)

NCx5710y is designed to support two different power supply configurations, bipolar or unipolar power supply. For reliable high output current delivery suitable external power capacitors are required. Parallel combination of 100 nF + $4.7~\mu F$ ceramic capacitors is optimal for a wide range of applications using power switch. For reliable driving of power switch modules (containing several parallel power switches) a higher capacity is required (typically 100 nF + $10~\mu F$). Capacitors should be as close as possible to the driver's power pins.

- In bipolar power supply the driver is typically supplied with a positive voltage of 15 V at VDD2 and negative voltage –5 V at VEE2 (Figure 41). Negative power supply prevents a dynamic turn on throughout the internal power switch input capacitance.
- In Unipolar power supply the driver is typically supplied with a positive voltage of 15 V at VDD2 (Figure 42). Dynamic turn on throughout the internal power switch input capacitance could be prevented by Active Miler Clamp function. CLAMP output should be directly connected to power switch gate (Figure 38).

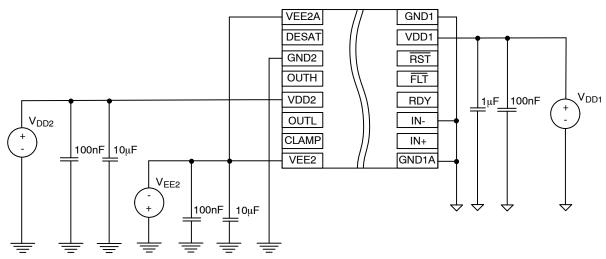


Figure 41. Bipolar Power Supply

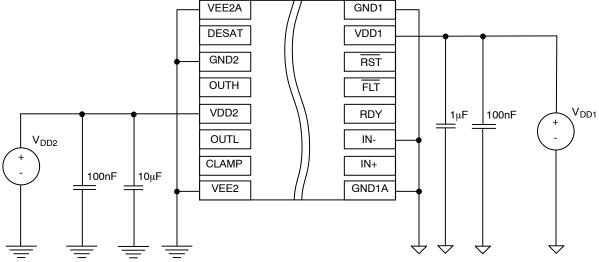


Figure 42. Unipolar Power Supply

Common Mode Transient Immunity (CMTI)

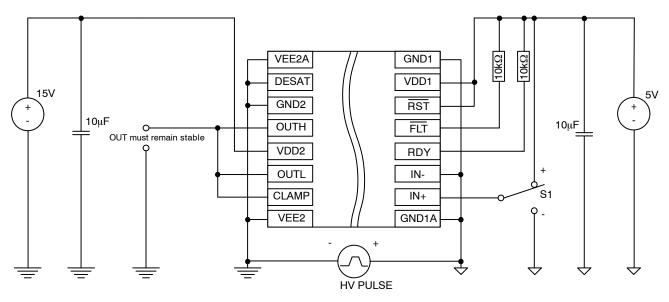


Figure 43. Common-Mode Transient Immunity Test Circuit

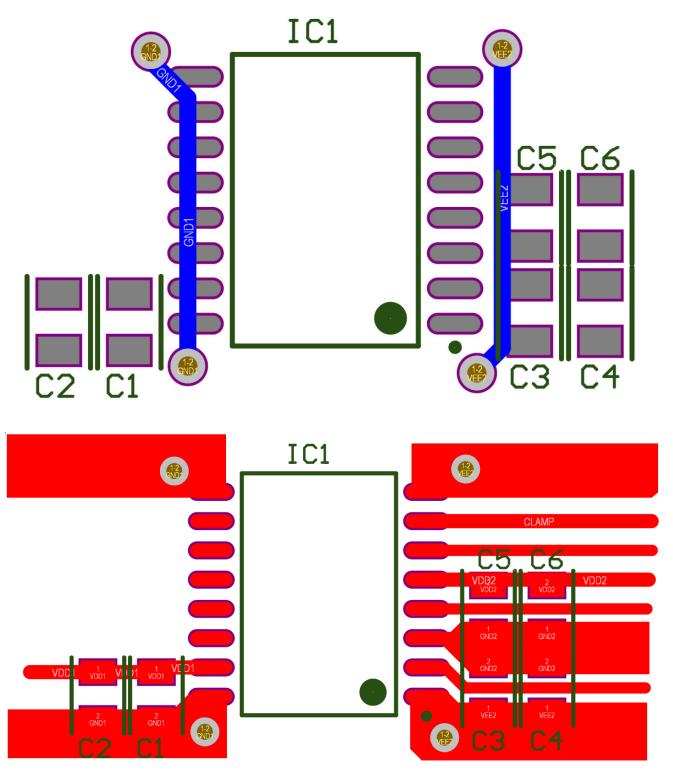


Figure 44. Recommended Basic Bipolar Power Supply PCB Design

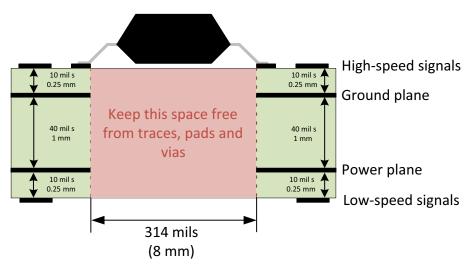


Figure 45. Recommended Layer Stack

PACKAGE DIMENSIONS

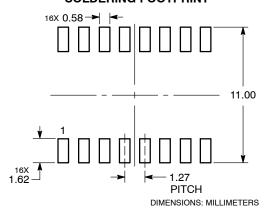
SOIC-16 WB

CASE 751G-03 ISSUE D $\frac{1}{16}$ \mathbb{H} \mathbb{H} \mathbb{H} \mathbb{H} \mathbb{H} \mathbb{H} \mathbb{H} \mathbb{H} (2) В I 3 h × 45 ă 0.25 Ф B 16X B 0.25 M T A S B S SEATING PLANE F

- DIMENSIONS ARE IN MILLIMETERS.
- INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
- DIMENSIONS D AND E DO NOT INLCUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
 DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR
 PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF THE B DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS					
DIM	MIN	MAX				
Α	2.35	2.65				
A1	0.10	0.25				
В	0.35	0.49				
С	0.23	0.32				
D	10.15	10.45				
Е	7.40	7.60				
е	1.27	BSC				
Н	10.05	10.55				
h	0.25	0.75				
L	0.50	0.90				
a	0 °	7 °				

SOLDERING FOOTPRINT



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